

1-Mbit (128 K × 8) Static RAM

Features

- Pin- and function-compatible with CY7C1018CV33 and CY7C1019CV33
- High speed
 □ t_{AA} = 10 ns
- Low Active Power
 □ I_{CC} = 60 mA @ 10 ns
- Low CMOS Standby Power
 □ I_{SB2} = 3 mA
- 2.0 V Data retention
- Automatic power-down when deselected
- CMOS for optimum speed/power
- Center power/ground pinout
- Easy memory expansion with CE and OE options
- Available in Pb-free 32-pin 400-Mil wide Molded SOJ, 32-pin TSOP II and 48-ball VFBGA packages

Functional Description

The CY7C1018DV33/CY7C1019DV33 is a high-performance CMOS static RAM organized as 131,072 words by 8 bits. Easy memory expansion is provided by an active LOW Chip Enable (CE), an active LOW Output Enable (OE), and three-state drivers. This device has an automatic power-down feature that significantly reduces power consumption when deselected.

Writing to the device is accomplished by taking Chip Enable (\overline{CE}) and Write Enable (\overline{WE}) inputs LOW. Data on the eight I/O pins $(I/O_0$ through $I/O_7)$ is then written into the location specified on the address pins $(A_0$ through A_{16}).

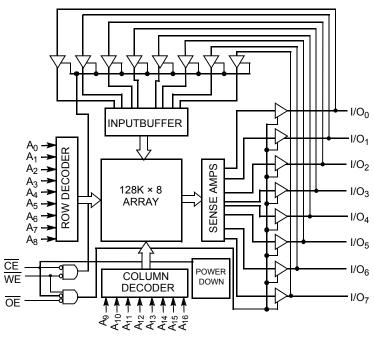
Reading from the device is accomplished by taking Chip Enable (\overline{CE}) and Output Enable (\overline{OE}) LOW while forcing Write Enable (\overline{WE}) HIGH. Under these conditions, the contents of the memory location specified by the address pins will appear on the I/O pins.

The eight input/output pins (I/O₀ through I/O₇) are <u>placed</u> in a high-impedance state when the device is deselected (CE HIGH), the outputs are <u>disabled</u> (\overline{OE} HIGH), or during a write operation (\overline{CE} LOW, and \overline{WE} LOW).

The CY7C1018DV33/CY7C1019DV33 are available in Pb-free 32-pin 400-Mil wide Molded SOJ, 32-pin TSOP II and 48-ball VFBGA packages.

For a complete list of related documentation, click here.

Logic Block Diagram





Contents

Selection Guide	3
Pin Configurations	3
Maximum Ratings	4
Operating Range	4
Electrical Characteristics	
Capacitance	5
Thermal Resistance	
AC Test Loads and Waveforms	5
Data Retention Characteristics	6
Data Retention Waveform	6
Switching Characteristics	
Switching Waveforms	
Truth Table	

Ordering Information	12
Ordering Code Definitions	
Package Diagrams	
Acronyms	17
Document Conventions	
Units of Measure	17
Document History Page	18
Sales, Solutions, and Legal Information	19
Worldwide Sales and Design Support	19
Products	19
PSoC® Solutions	19
Cypress Developer Community	19
Technical Support	



Selection Guide

Description	-10 (Industrial)	Unit
Maximum Access Time	10	ns
Maximum Operating Current	60	mA
Maximum Standby Current	3	mA

Pin Configurations

Figure 1. 48-ball VFBGA pinout (Top View) [1]

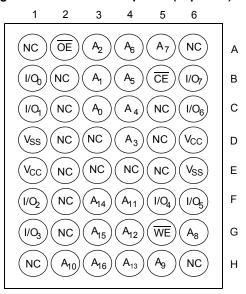
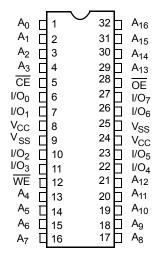


Figure 2. 32-pin SOJ / TSOP II pinout (Top View)



Note

^{1.} NC pins are not connected on the die.



Maximum Ratings

DC Input Voltage [2]	0.3 V to V _{CC} + 0.3 V
Current into Outputs (LOW)	20 mA
Static Discharge Voltage (per MIL-STD-883, Method 3015) .	> 2001 V
Latch-up Current	> 200 mA

Operating Range

Range	Ambient Temperature	V _{cc}	Speed	
Industrial	–40 °C to +85 °C	$3.3~V\pm0.3~V$	10 ns	

Electrical Characteristics

Over the Operating Range

Dorometer	Description	Test Conditions		-10 (Industrial)		I I m!4
Parameter	Description	rest conditions		Min	Max	Unit
V _{OH}	Output HIGH voltage	Min V _{CC} , I _{OH} = –4.0 mA		2.4	-	V
V _{OL}	Output LOW voltage	Min V _{CC} , I _{OL} = 8.0 mA		-	0.4	V
V _{IH}	Input HIGH voltage			2.0	V _{CC} + 0.3	V
V _{IL}	Input LOW voltage [2]					V
I _{IX}	Input leakage current	$GND \le V_{IN} \le V_{CC}$		-1	+1	μΑ
I _{OZ}	Output leakage current	$GND \le V_{IN} \le V_{CC}$, output disabled		-1	+1	μΑ
I _{CC}	V _{CC} operating supply current	V _{CC} = Max, I _{OUT} = 0 mA,	100 MHz	-	60	mA
		$f = f_{MAX} = 1/t_{RC}$	83 MHz	-	55	mA
			66 MHz	-	45	mA
			40 MHz	-	30	mA
I _{SB1}	Automatic CE power-down current – TTL inputs	$\begin{aligned} &\text{Max V}_{CC}, \overline{CE} \geq \text{V}_{IH}, \\ &\text{V}_{IN} \geq \text{V}_{IH} \text{ or V}_{IN} \leq \text{V}_{IL}, f = \text{f}_{MAX} \end{aligned}$		_	10	mA
I _{SB2}	Automatic CE power-down current – CMOS inputs	$\begin{array}{l} \text{Max V}_{\text{CC}}, \overline{\text{CE}} \geq \text{V}_{\text{CC}} - 0.3 \text{ V}, \\ \text{V}_{\text{IN}} \geq \text{V}_{\text{CC}} - 0.3 \text{ V or V}_{\text{IN}} \leq 0.3 \text{ V}, \text{f} = \\ \end{array}$	0	_	3	mA

^{2.} $V_{IL(min)}$ = -2.0 V and $V_{IH(max)}$ = V_{CC} + 1 V for pulse durations of less than 5 ns.



Capacitance

Parameter [3]	Description	Test Conditions	Max	Unit
C _{IN}	Input Capacitance	$T_A = 25 ^{\circ}\text{C}, f = 1 \text{MHz}, V_{CC} = 3.3 \text{V}$	8	pF
C _{OUT}	Output Capacitance		8	pF

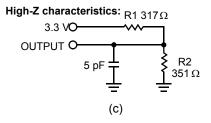
Thermal Resistance

Parameter [3]	Description	Test Conditions	32-pin SOJ	32-pin TSOP II	48-ball VFBGA	Unit
Θ_{JA}	(Junction to Ambient)	Still Air, soldered on a 3 × 4.5 inch, four-layer printed circuit		62.22	36	°C/W
$\Theta_{\sf JC}$	Thermal Resistance (Junction to Case)	board	38.14	21.43	9	°C/W

AC Test Loads and Waveforms

Figure 3. AC Test Loads and Waveforms [4]





Notes

- Tested initially and after any design or process changes that may affect these parameters.
- 4. AC characteristics (except High Z) are tested using the load conditions shown in Figure 3 (a). High Z characteristics are tested for all speeds using the test load shown in Figure 3 (c).



Data Retention Characteristics

Over the Operating Range

Parameter	Description	Conditions	Min	Max	Unit
V _{DR}	V _{CC} for data retention		2.0	-	V
I _{CCDR}	Data retention current	$V_{CC} = V_{DR} = 2.0 \text{ V}, \overline{CE} \ge V_{CC} - 0.3 \text{ V},$ $V_{IN} \ge V_{CC} - 0.3 \text{ V} \text{ or } V_{IN} \le 0.3 \text{ V}$	_	3	mA
t _{CDR} ^[5]	Chip deselect to data retention time		0	_	ns
t _R ^[6]	Operation recovery time		t _{RC}	_	ns

Data Retention Waveform

Figure 4. Data Retention Waveform



- 5. Tested initially and after any design or process changes that may affect these parameters.
 6. Full device operation requires linear V_{CC} ramp from V_{DR} to V_{CC(min.)} ≥ 50 μs or stable at V_{CC(min.)} ≥ 50 μs.



Switching Characteristics

Over the Operating Range

Parameter [7]	Description	-10 (Inc	dustrial)	11:4
Parameter 11	Description		Max	Unit
Read Cycle			•	•
t _{power} [8]	V _{CC} (typical) to the first access	100	_	μS
t _{RC}	Read cycle time	10	_	ns
t _{AA}	Address to data valid	-	10	ns
t _{OHA}	Data hold from address change	3	_	ns
t _{ACE}	CE LOW to data valid	-	10	ns
t _{DOE}	OE LOW to data valid	-	5	ns
t _{LZOE}	OE LOW to low Z [9]	0	_	ns
t _{HZOE}	OE HIGH to high Z [9, 10]	-	5	ns
t _{LZCE}	CE LOW to low Z [9]	3	_	ns
t _{HZCE}	CE HIGH to high Z [9, 10]	_	5	ns
t _{PU} ^[11]	CE LOW to power-up	0	_	ns
t _{PD} ^[11]	CE HIGH to power-down	-	10	ns
Write Cycle [12	, 13]			•
t _{WC}	Write cycle time	10	_	ns
t _{SCE}	CE LOW to write end	8	_	ns
t _{AW}	Address set-up to write end	8	_	ns
t _{HA}	Address hold from write end	0	_	ns
t _{SA}	Address set-up to write start	0	_	ns
t _{PWE}	WE pulse width	7	_	ns
t _{SD}	Data set-up to write end	5	_	ns
t _{HD}	Data hold from write end	0	_	ns
t _{LZWE}	WE HIGH to low Z [9]	3	_	ns
t _{HZWE}	WE LOW to high Z ^[9, 10]	_	5	ns

- 7. Test conditions assume signal transition time of 3 ns or less, timing reference levels of 1.5 V, input pulse levels of 0 to 3.0 V.

- the continuous assume signal transition that the power supply should be at typical V_{CC} values until the first memory access can be performed.

 by the continuous assume signal transition that the power supply should be at typical V_{CC} values until the first memory access can be performed.

 continuous assume signal transition that the power supply should be at typical V_{CC} values until the first memory access can be performed.

 continuous that the power supply should be at typical V_{CC} values until the first memory access can be performed.

 continuous that the power supply should be at typical V_{CC} values until the first memory access can be performed.

 continuous that the power supply should be at typical V_{CC} values until the first memory access can be performed.

 continuous that the power supply should be at typical V_{CC} values until the first memory access can be performed.

 continuous that the power supply should be at typical V_{CC} values until the first memory access can be performed.

 continuous that the power supply should be at typical V_{CC} values until the first memory access can be performed.

 continuous that the power supply should be at typical V_{CC} values until the first memory access can be performed.

 continuous that the power supply should be at typical V_{CC} values until the first memory access can be performed.

 continuous that the power supply should be at typical V_{CC} values until the first memory access can be performed.

 continuous that the power supply should be at typical V_{CC} values until the first memory access can be performed.

 continuous that the power supply should be at typical V_{CC} values until the first memory access can be performed.

 continuous that the power supply should be at typical V_{CC} values until the first memory access can be performed.

 continuous that the power supply should be at typical V_{CC} values until the first memory access can be performed.

 continuous that the power supply should be at typical V_{CC} values until the first memory access can be
- 12. The internal write time of the memory is defined by the overlap of CE LOW and WE LOW. CE and WE must be LOW to initiate a write, and the transition of any of these signals can terminate the write. The input data set-up and hold timing should be referenced to the leading edge of the signal that terminates the write.

 13. The minimum write cycle time for Write Cycle no. 3 (WE controlled, OE LOW) is the sum of t_{HZWE} and t_{SD}.



Switching Waveforms

Figure 5. Read Cycle No. 1 (Address Transition Controlled) [14, 15]

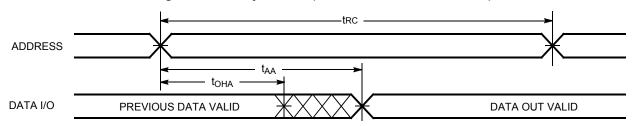
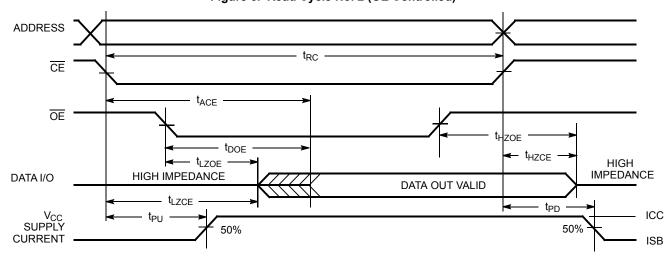


Figure 6. Read Cycle No. 2 ($\overline{\text{OE}}$ Controlled) [15, 16]



Notes

^{14. &}lt;u>Dev</u>ice is continuously selected. OE, CE = V_{IL}.

15. WE is HIGH for Read cycle.

16. Address valid prior to or coincident with CE transition LOW.



Switching Waveforms (continued)

Figure 7. Write Cycle No. 1 (CE Controlled) [17, 18]

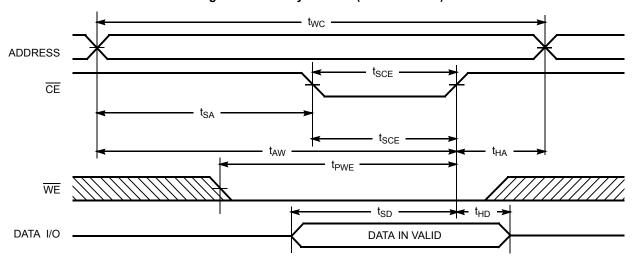
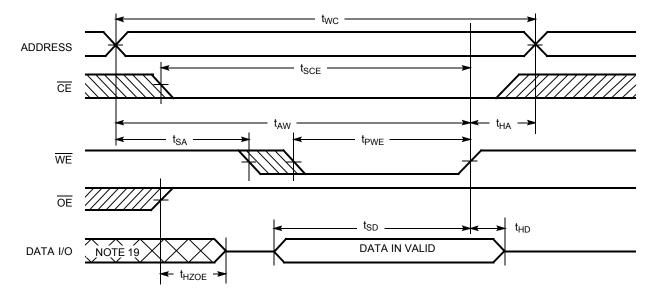


Figure 8. Write Cycle No. 2 (WE Controlled, OE HIGH During Write) [17, 18]



Notes

^{17.} Data I/O is high impedance if $\overline{OE} = V_{IJ}$.

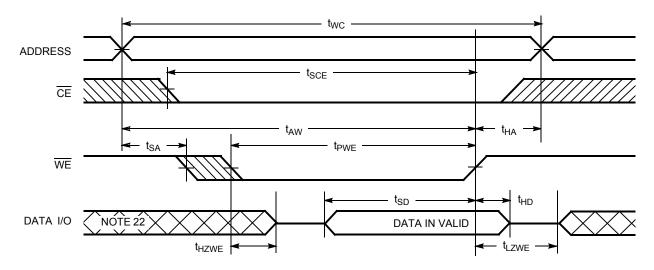
18. If \overline{CE} goes HIGH simultaneously with WE going HIGH, the output remains in a high-impedance state.

^{19.} During this period the I/Os are in the output state and input signals should not be applied.



Switching Waveforms (continued)

Figure 9. Write Cycle No. 3 (WE Controlled, OE LOW) [20, 21]



^{20.} If CE goes HIGH simultaneously with WE going HIGH, the <u>output</u> remains in a high-impedance state.

21. The minimum write cycle time for Write Cycle no. 3 (WE controlled, OE LOW) is the sum of t_{HZWE} and t_{SD}.

22. During this period the I/Os are in the output state and input signals should not be applied.



Truth Table

CE	OE	WE	I/O ₀ –I/O ₇	Mode	Power
Н	Х	Х	High Z	Power-Down	Standby (I _{SB})
L	L	Н	Data Out	Read	Active (I _{CC})
L	Х	L	Data In	Write	Active (I _{CC})
L	Н	Н	High Z	Selected, Outputs Disabled	Active (I _{CC})

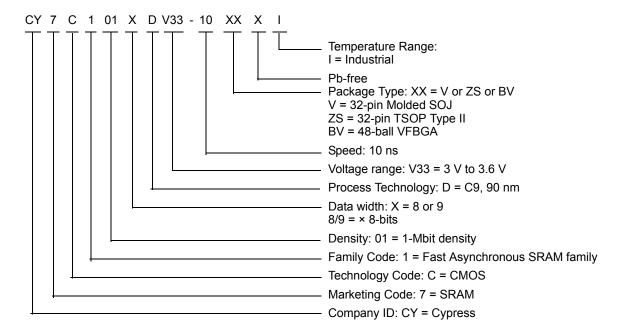


Ordering Information

Speed (ns)	Ordering Code	Package Diagram	Package Type	Operating Range
10	CY7C1018DV33-10VXI	51-85041	32-pin (300-Mil) Molded SOJ (Pb-free)	Industrial
	CY7C1019DV33-10VXI	51-85033	32-pin (400-Mil) Molded SOJ (Pb-free)	
	CY7C1019DV33-10ZSXI	51-85095	32-pin TSOP Type II (Pb-free)	
	CY7C1019DV33-10BVXI	51-85150	48-ball VFBGA (Pb-free)	

Please contact your local Cypress sales representative for availability of these parts.

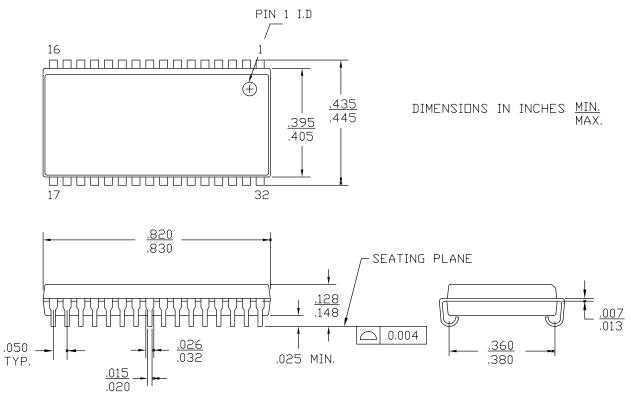
Ordering Code Definitions





Package Diagrams

Figure 10. 32-pin SOJ (400 Mils) V32.4 (Molded SOJ V33) Package Outline, 51-85033

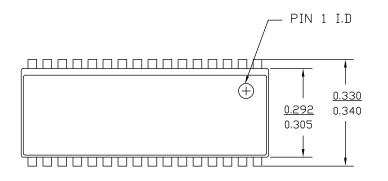




Package Diagrams (continued)

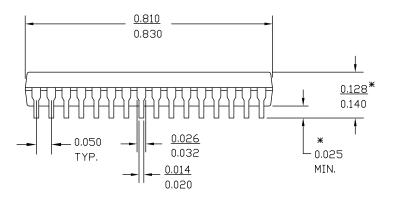
Figure 11. 32-pin SOJ (300 Mils) V32.3 (Catalog 32.3 Molded SOJ) Package Outline, 51-85041

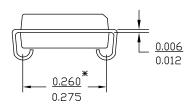
32 Lead (300 MIL) Molded SOJ



DIMENSIONS IN INCHES MIN. MAX.

LEAD COPLANARITY 0.004 MAX.



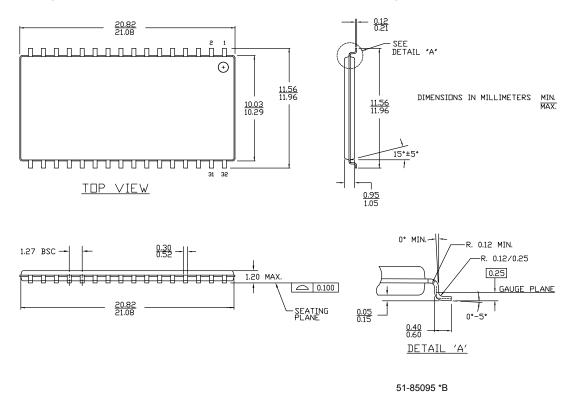


51-85041 Rev. *D



Package Diagrams (continued)

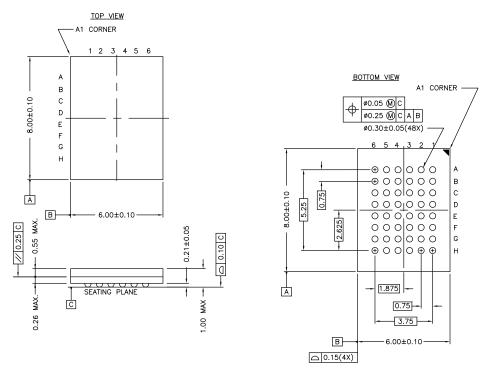
Figure 12. 32-pin TSOP II (20.95 × 11.76 × 1.0 mm) ZS32 Package Outline, 51-85095





Package Diagrams (continued)

Figure 13. 48-ball VFBGA (6 × 8 × 1.0 mm) BV48/BZ48 Package Outline, 51-85150



NOTE:
PACKAGE WEIGHT: See Cypress Package Material Declaration Datasheet (PMDD) posted on the Cypress web.

51-85150 *H



Acronyms

Acronym	Description			
CE	Chip Enable			
CMOS	Complementary Metal Oxide Semiconductor			
I/O	Input/Output			
OE	Output Enable			
SOJ	Small Outline J-lead			
SRAM	Static Random Access Memory			
TSOP	Thin Small Outline Package			
TTL	Transistor-Transistor Logic			
VFBGA	Very Fine-Pitch Ball Grid Array			
WE	Write Enable			

Document Conventions

Units of Measure

Symbol	Unit of Measure		
°C	degree Celsius		
MHz	megahertz		
μΑ	microampere		
μS	microsecond		
mA	milliampere		
mm	millimeter		
ns	nanosecond		
Ω	ohm		
%	percent		
pF	picofarad		
V	volt		
W	watt		



Document History Page

Documer Documer	Oocument Title: CY7C1018DV33/CY7C1019DV33, 1-Mbit (128 K × 8) Static RAM Oocument Number: 38-05481					
Rev.	ECN No.	Issue Date	Orig. of Change	Description of Change		
**	201560	See ECN	SWI	Advance Information data sheet for C9 IPP		
*A	233750	See ECN	RKF	DC parameters modified as per EROS (Spec # 01-02165 Rev *A) Pb-free Offering in Ordering Information		
*B	262950	See ECN	RKF	Added Data Retention Characteristics table Added T _{power} Spec in Switching Characteristics table Shaded Ordering Information		
*C	307598	See ECN	RKF	Reduced Speed bins to -8 and -10 ns		
*D	520652	See ECN	VKN	Changed status from Preliminary to Final Removed Commercial Operating range Removed 8 ns speed bin Added I _{CC} values for the frequencies 83 MHz, 66 MHz and 40 MHz Added 48-ball VFBGA package Updated Thermal Resistance table Updated Ordering Information table Changed Overshoot spec from V _{CC} + 2 V to V _{CC} + 1 V in footnote #3		
*E	3110052	12/14/2010	AJU	Added Ordering Code Definitions. Updated Package Diagrams.		
*F	3416342	10/20/2011	TAVA	Updated Functional Description (Removed the Note "For guidelines on SRAM system design, please refer to the 'System Design Guidelines' Cypress application note, available on the internet at www.cypress.com." and its reference in Functional Description). Updated Electrical Characteristics. Updated Switching Waveforms. Updated Package Diagrams. Added Acronyms and Units of Measure. Updated in new template.		
*G	4324792	03/28/2014	VINI	Added CY7C1018DV33 related information across the document. Updated Ordering Information (Updated part numbers). Updated Package Diagrams: spec 51-85033 – Changed revision from *D to *E. spec 51-85150 – Changed revision from *G to *H. Updated in new template.		
*H	4531367	10/10/2014	NILE	Corrected the package diagram reference for CY7C1018DV33 in (Updated part numbers). Added 51-85041: 32-pin (300 Mil) Molded SOJ in Package Diagrams:		
*	4574311	11/19/2014	NILE	Added related documentation hyperlink in page 1. Updated Figure 11 in Package Diagrams (spec 51-85041 Rev. *C to *D).		



Sales, Solutions, and Legal Information

Worldwide Sales and Design Support

Cypress maintains a worldwide network of offices, solution centers, manufacturer's representatives, and distributors. To find the office closest to you, visit us at Cypress Locations.

Products

Automotive Clocks & Buffers Interface

Lighting & Power Control

Memory
PSoC
Touch Sensing
USB Controllers
Wireless/RF

cypress.com/go/automotive cypress.com/go/clocks cypress.com/go/interface cypress.com/go/powerpsoc cypress.com/go/plc cypress.com/go/memory cypress.com/go/psoc cypress.com/go/touch cypress.com/go/USB cypress.com/go/wireless

PSoC® Solutions

psoc.cypress.com/solutions PSoC 1 | PSoC 3 | PSoC 4 | PSoC 5LP

Cypress Developer Community

Community | Forums | Blogs | Video | Training

Technical Support

cypress.com/go/support

© Cypress Semiconductor Corporation, 2004-2014. The information contained herein is subject to change without notice. Cypress Semiconductor Corporation assumes no responsibility for the use of any circuitry other than circuitry embodied in a Cypress product. Nor does it convey or imply any license under patent or other rights. Cypress products are not warranted nor intended to be used for medical, life support, life saving, critical control or safety applications, unless pursuant to an express written agreement with Cypress. Furthermore, Cypress does not authorize its products for use as critical components in life-support systems where a malfunction or failure may reasonably be expected to result in significant injury to the user. The inclusion of Cypress products in life-support systems application implies that the manufacturer assumes all risk of such use and in doing so indemnifies Cypress against all charges.

Any Source Code (software and/or firmware) is owned by Cypress Semiconductor Corporation (Cypress) and is protected by and subject to worldwide patent protection (United States and foreign), United States copyright laws and international treaty provisions. Cypress hereby grants to licensee a personal, non-exclusive, non-transferable license to copy, use, modify, create derivative works of, and compile the Cypress Source Code and derivative works for the sole purpose of creating custom software and or firmware in support of licensee product to be used only in conjunction with a Cypress integrated circuit as specified in the applicable agreement. Any reproduction, modification, translation, compilation, or representation of this Source Code except as specified above is prohibited without the express written permission of Cypress.

Disclaimer: CYPRESS MAKES NO WARRANTY OF ANY KIND, EXPRESS OR IMPLIED, WITH REGARD TO THIS MATERIAL, INCLUDING, BUT NOT LIMITED TO, THE IMPLIED WARRANTIES OF MERCHANTABILITY AND FITNESS FOR A PARTICULAR PURPOSE. Cypress reserves the right to make changes without further notice to the materials described herein. Cypress does not assume any liability arising out of the application or use of any product or circuit described herein. Cypress does not authorize its products for use as critical components in life-support systems where a malfunction or failure may reasonably be expected to result in significant injury to the user. The inclusion of Cypress' product in a life-support systems application implies that the manufacturer assumes all risk of such use and in doing so indemnifies Cypress against all charges.

Use may be limited by and subject to the applicable Cypress software license agreement.